

• General Description

It combines trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

• Features

- AEC-Q101 Qualified
- Low $R_{DS(ON)}$ to minimize conductive loss
- High GOX reliability
- Low Thermal resistance

• Application

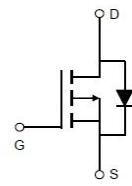
- BLDC Motor driver
- DC-DC
- Load Switch

• Ordering Information:

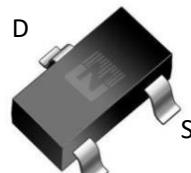
Part NO.	ZMA019KP06T
Marking	019KP06
Packing Information	REEL TAPE
Basic ordering unit (pcs)	3000

• Absolute Maximum Ratings ($T_C=25^\circ\text{C}$)

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	V_{DS}		-60	V
Gate-Source Voltage	V_{GS}		± 20	V
Continuous Drain Current	I_D	$T_C=25^\circ\text{C}$	-1.8	A
	I_D	$T_C=75^\circ\text{C}$	-1.40	A
	I_D	$T_C=100^\circ\text{C}$	-1.14	A
Pulsed Drain Current	I_{DM}	Pulsed; $t_p \leq 10 \mu\text{s}$; $T_{mb} = 25^\circ\text{C}$	-7.2	A
Total Power Dissipation	P_D	$T_C=25^\circ\text{C}$	2	W
Total Power Dissipation	P_D	$T_A=25^\circ\text{C}$	0.7	W
Operating Junction Temperature	T_J		-55 to +150	$^\circ\text{C}$
Storage Temperature	T_{STG}		-55 to +150	$^\circ\text{C}$
Single Pulse Avalanche Energy	E_{AS}	$L=0.1\text{mH}$, $V_{GS}=-10\text{V}$, $R_g=25\Omega$,	1	mJ
		$L=0.5\text{mH}$, $V_{GS}=-10\text{V}$, $R_g=25\Omega$,	2.1	mJ
ESD Level (HBM)			CLASS 2	



$V_{DS} = -60\text{V}$
 $R_{DS(ON)} = 190\text{m}\Omega$
 $I_D = -1.8\text{A}$



HF

•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R _{thJC}		-	80	°C/W
Thermal resistance, junction-ambient ^①	R _{thJA}		-	180	°C/W
Soldering temperature	T _{sold}		-	260	°C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D = -250uA	-60			V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D = -250uA	-1.3	-1.8	-2.5	V
Drain-Source Leakage Current	I _{DSS}	V _{GS} =0V, V _{DS} = -60V			1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} = 0V			100	nA
Static Drain-source On Resistance	R _{DS(ON)}	V _{GS} =-10V, I _D = -1.5A		190	250	mΩ
		V _{GS} =-4.5V, I _D = -1A		230	310	mΩ
Forward Transconductance	g _{FS}	V _{DS} =-5V, I _{SD} = -1A		1.9		s
Diode Forward Voltage	V _{FSD}	V _{GS} =0V, I _{SD} = -1.5A			1.3	V

•Dynamic characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C _{iss}	f = 1MHz, V _{DS} =-25V	-	336	-	pF
Output capacitance	C _{oss}		-	49	-	
Reverse transfer capacitance	C _{rss}		-	36	-	
Gate Resistance	R _g	f = 1MHz	-	7		Ω
Total gate charge	Q _g	V _{DD} = -15V, I _D = -1A, = -10V	-	7.2	-	nC
	Q _{g(-4.5v)}		-	21	-	
Gate - Source charge	Q _{gs}		-	1.6	-	
Gate - Drain charge	Q _{gd}		-	3	-	
Turn-ON Delay time	t _{D(on)}	V _{GS} =-10V, V _{DS} =-15V, R _G =3.3Ω, I _D =-1A	-	6.5	-	ns
Turn-ON Rise time	t _r		-	8	-	ns
Turn-Off Delay time	t _{D(off)}		-	16.5	-	ns
Turn-Off Fall time	t _f		-	4	-	ns



Fig.1 Gate-Charge Characteristics

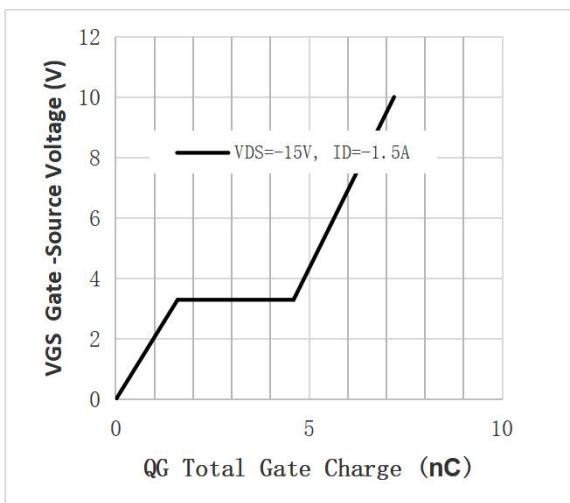


Fig.2 Capacitance Characteristics

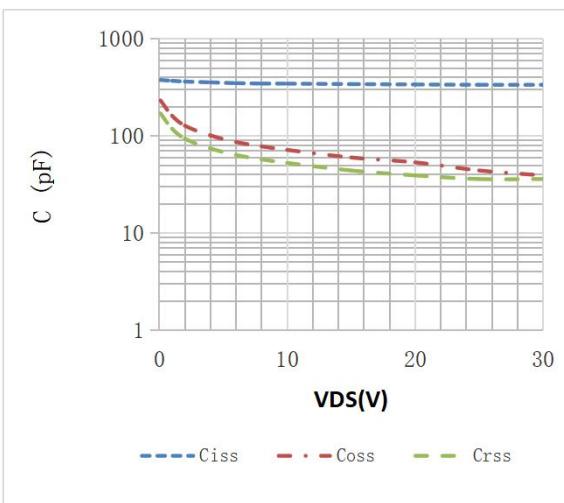


Fig.3 Power Dissipation

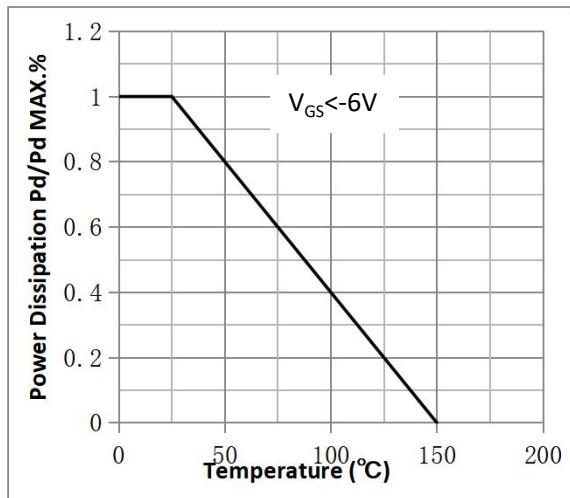


Fig.5 Threshold Voltage V.S Junction Temperature

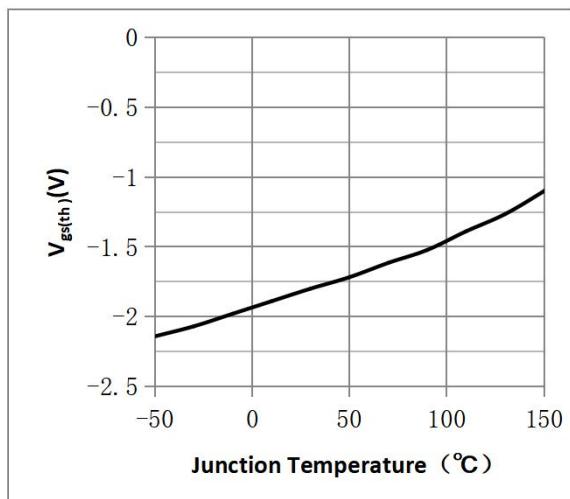


Fig.4 Typical output Characteristics

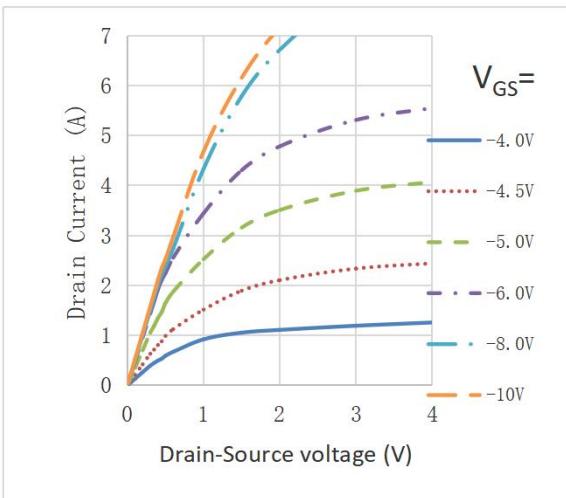


Fig.6 Resistance V.S Drain Current

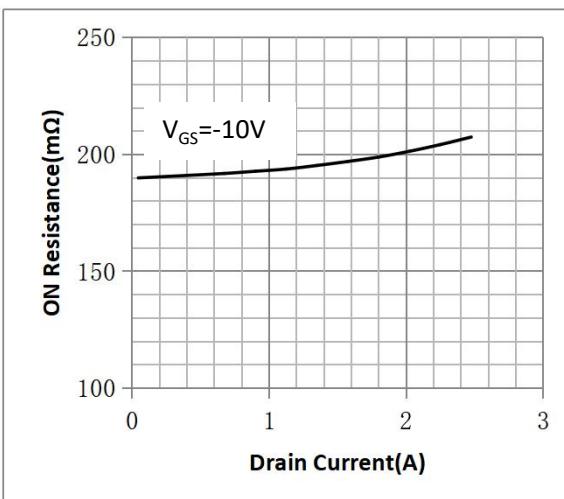


Fig.7 On-Resistance VS Gate Source Voltage

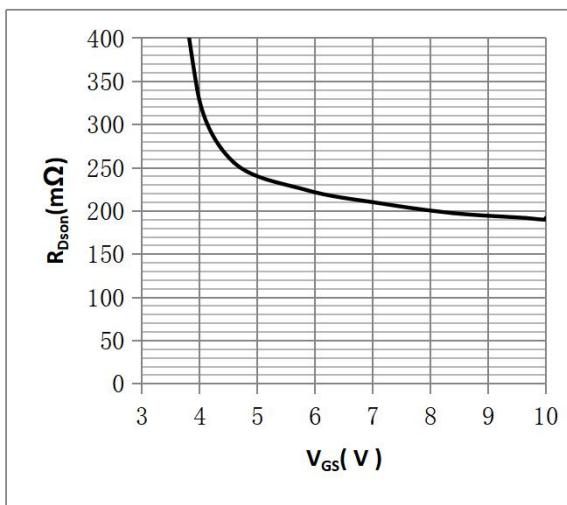


Fig.8 On-Resistance V.S Junction Temperature

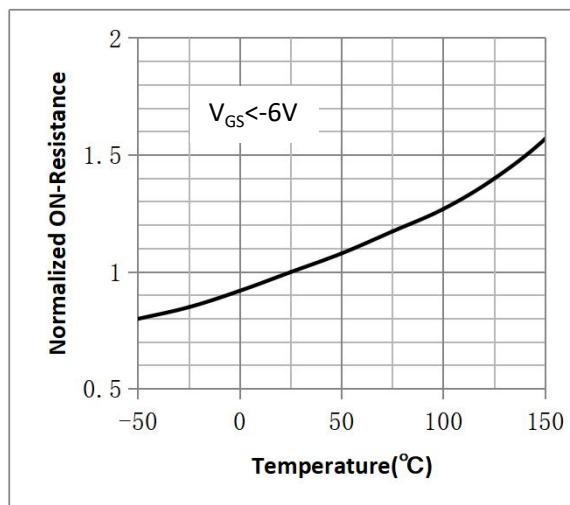


Figure 9. Diode Forward Voltage vs. Current

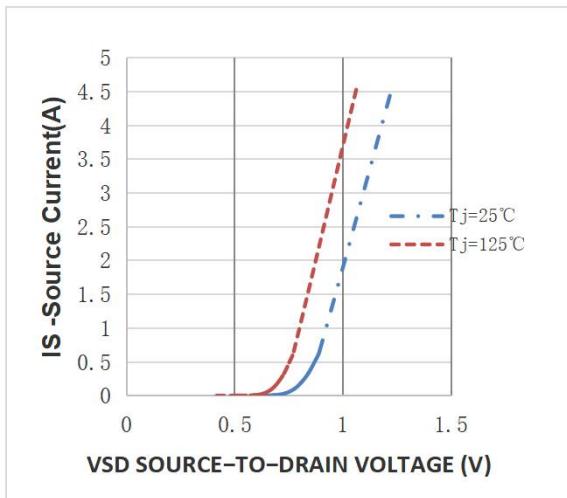


Figure 10. Transfer Characteristics

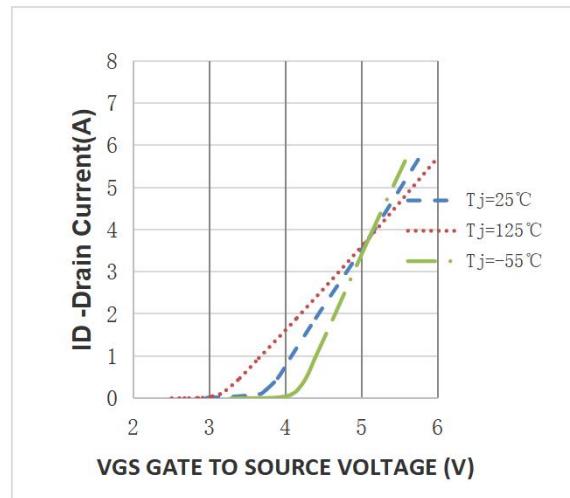


Fig.11 Safe Operating Area

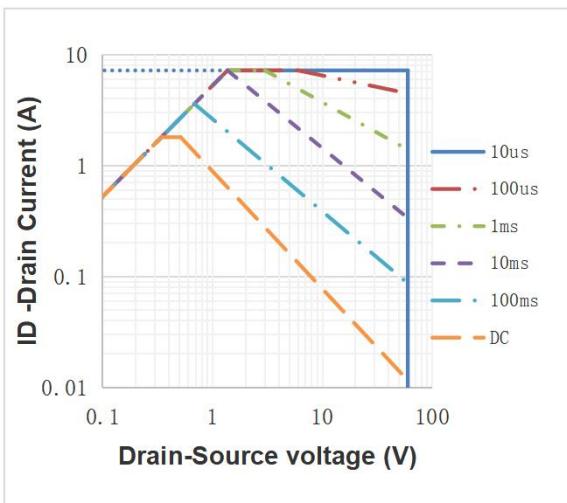
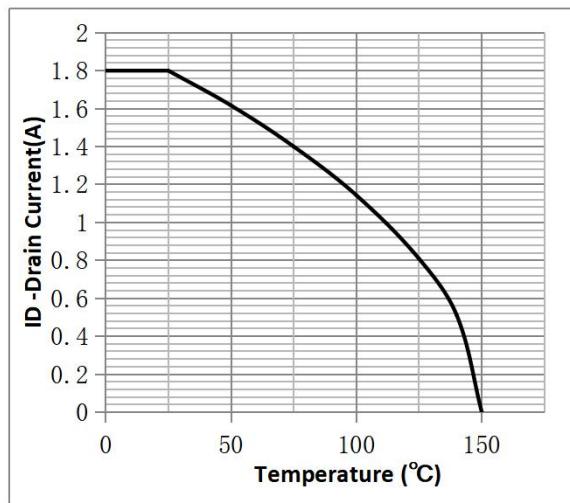
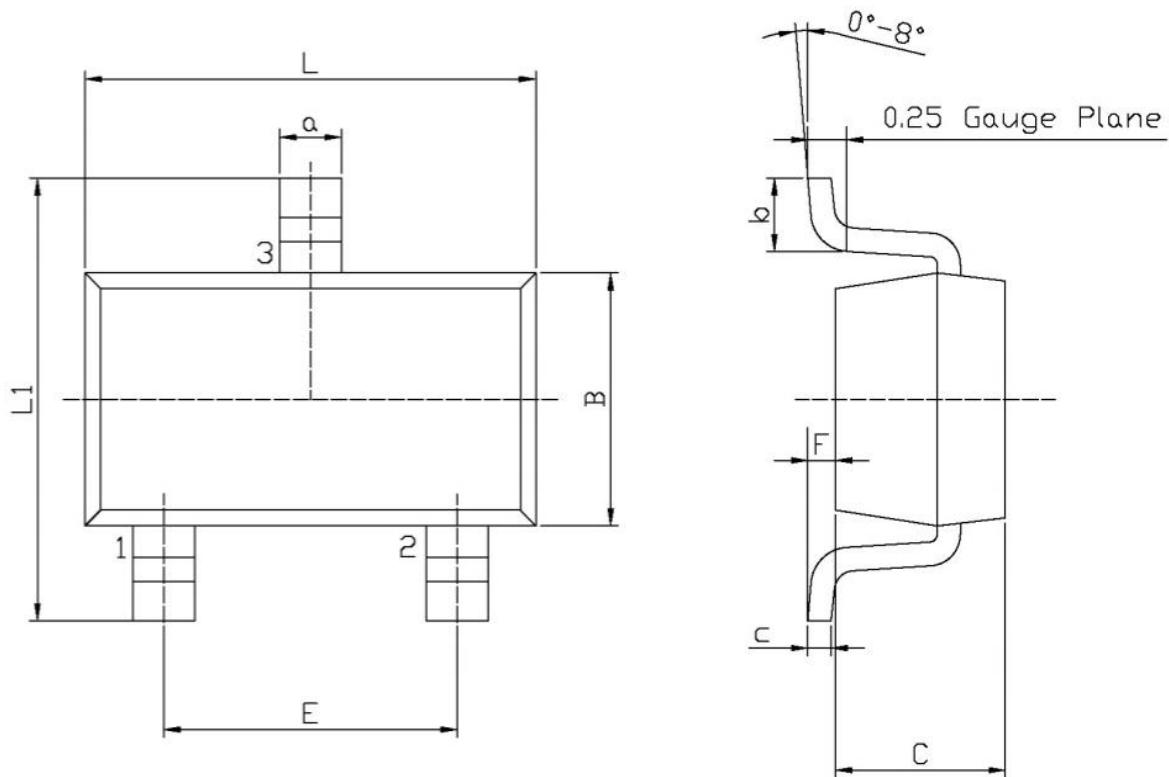


Fig.12 ID vs. Case Temperature^②





•SOT-23-3 Package Outline



Unit: mm

Symbol	Dimensions In Millimeters		Symbol	Dimensions In Millimeters	
	Min	Max		Min	Max
L	2.82	3.02	a	0.35	0.50
B	1.50	1.70	c	0.10	0.20
C	0.90	1.30	b	0.35	0.55
L1	2.60	3.00	F	0	0.15
E	1.80	2.00			

Note:

- ① Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ② Practically the current will be limited by PCB, thermal design and operating temperature. VGS=-10V.

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Revision History

Version	Date	Change
A	2022.10.16	NEW
B	2023.12.7	1.Add Reach,HF figure